Search Notes		

Application	No.	Applicant(s)	
10/699,263	i.	YOSHITOMI ET	AL.
Examiner		Art Unit	
Patrick Mil	ler	2837	

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Class	Subclass	Date	Examiner
318	254,439,6 96,138	9/6/2004	РМ
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
circulation; flyback; freewheeling; diode; absolute value/magnitude; Hall; integrated circuit/ASIC	9/6/2004	РМ